



CoreGaN 650V GaN HEMT

Description

The CE65H080TOCI Series 650V, 80mΩ gallium nitride (GaN) FETs are normally-off devices.

Coreenergy GaN FETs offer better efficiency through lower gate charge, faster switching speeds, and lower dynamic on-resistance, delivering significant advantages over traditional silicon (Si) devices.

Coreenergy is a leading-edge wide band gap supplier with world-class innovation .

Application

- Adapter
- Renewable energy
- Telecom and data-com
- Servo motors
- Industrial
- Automotive

General Features

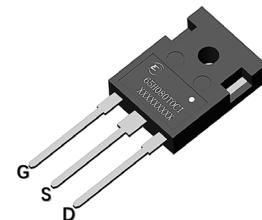
- Easy to drive—compatible with standard gate drivers
- Low conduction and switching losses
- RoHS compliant and Halogen-free

Benefits

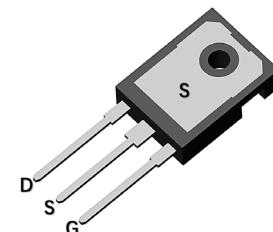
- Increased efficiency through fast switching
- Increased power density
- Reduced system size and weight

Ordering Information

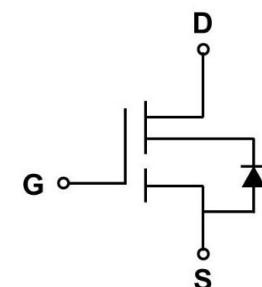
Part Number	Package	Package Configuration
CE65H080TOCI	TO247	Source



Top



Bottom



Circuit Symbol

Features

BV_{DSS}	$R_{DS(on)}$	I_{DS}	Q_G
650V	80mΩ	26A	10.9 nC



CE65H080TOCI

Absolute Maximum Ratings

$T_c=25^\circ\text{C}$ unless otherwise stated

Symbol	Parameter	Limit value	Unit
V_{DSS}	Drain to source voltage ($T_j = -55^\circ\text{C}$ to 150°C)	650	
$V_{(TR)DSS}$	Drain to source voltage-transient ^a	800	V
V_{GSS}	Gate to source voltage	-20~+20	
I_D	Continuous drain current @ $T_c=25^\circ\text{C}$ ^b	26	A
	Continuous drain current @ $T_c=125^\circ\text{C}$	11.7	
I_{DM}	Pulse drain current (pulse width: 10μs)	75	A
P_D	Maximum power dissipation @ $T_c=25^\circ\text{C}$	113	W
T_c	Operating temperature	Case	${}^\circ\text{C}$
T_j		Junction	${}^\circ\text{C}$
T_s	Storage temperature	-55~150	${}^\circ\text{C}$

a. In off-state, spike duty cycle $D<0.01$, spike duration <1μs

b. For increased stability at high current operation



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Thermal Resistance

Symbol	Parameter	Limit value	Unit
R_{\thetaJC}	Junction-to-case	1.1	°C /W



Electrical Parameters

$T_J=25^\circ\text{C}$ unless otherwise stated

Symbol	Parameter	Min	Typ	Max	Unit	Test Conditions
Forward Device Characteristics						
$V_{(\text{BL})\text{DSS}}$	Drain-source voltage	650	-	-	V	$V_{GS}=0\text{V}$
$V_{GS(\text{th})}$	Gate threshold voltage	3	4	5	V	
$\Delta V_{GS(\text{th})}/T_J$	Gate threshold voltage temperature coefficient	-	-7	-	mV/°C	$V_{DS}=1\text{V}, I_{DS}=1\text{mA}$
$R_{DS(\text{on})}$	Drain-source on-Resistance	-	80	100	mΩ	$V_{GS}=10\text{V}, I_D=1\text{A}, T_J=25^\circ\text{C}$
		-	180	-		$V_{GS}=10\text{V}, I_D=1\text{A}, T_J=150^\circ\text{C}$
I_{DSS}	Drain-to-source leakage current	-	6	12	μA	$V_{DS}=650\text{V}, V_{GS}=0\text{V}, T_J=25^\circ\text{C}$
		-	10	100		$V_{DS}=650\text{V}, V_{GS}=0\text{V}, T_J=150^\circ\text{C}$
I_{GSS}	Gate-to-source forward leakage current	-	-	±100	nA	$V_{GS}=\pm 20\text{V}$
C_{ISS}	Input capacitance	-	729	-		
C_{OSS}	Output capacitance	-	75	-	pF	$V_{GS}=0\text{V}, V_{DS}=400\text{V}, f=1\text{MHz}$
C_{RSS}	Reverse capacitance	-	0.2	-		
Q_G	Total gate charge	-	10.9	-		
Q_{GS}	Gate-source charge	-	3.2	-	nC	$V_{DS}=400\text{V}, V_{GS}=0\text{V to } 10\text{V}, I_D=1\text{A}$
Q_{GD}	Gate-drain charge	-	3.4	-		
Q_{OSS}	Output charge	-	101	-	nC	$V_{GS}=0\text{V}, V_{DS}=0\text{V to } 400\text{V}, f=1\text{MHz}$
$t_{D(\text{on})}$	Turn-on delay	-	9	-		
t_R	Rise time	-	4	-		
$t_{D(\text{off})}$	Turn-off delay	-	22	-	ns	$V_{DS}=400\text{V}, V_{GS}=0\text{V to } 10\text{V}, I_D=2.1\text{A}, R_{G-on(ext)}=6.8\Omega, R_{G-off(ext)}=2.2\Omega, L=250\mu\text{H}$
t_F	Fall time	-	7	-		



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Electrical Parameters

$T_j=25^\circ\text{C}$ unless otherwise stated

Symbol	Parameter	Min	Typ	Max	Unit	Test Conditions
Reverse Device Characteristics						
V_{SD}	Source-Drain reverse voltage	-	1.9	-	V	$V_{GS}=0\text{V}$, $I_{SD}=15\text{A}$
t_{RR}	Reverse recovery time	-	52	-	ns	
Q_{RR}	Reverse recovery charge	-	40	-	nC	$I_F=10\text{A}$, $V_{DD}=400\text{V}$, $dI_F/dt=165\text{A}/\mu\text{s}$

Typical Characteristics

$T_j=25^\circ\text{C}$ unless otherwise stated

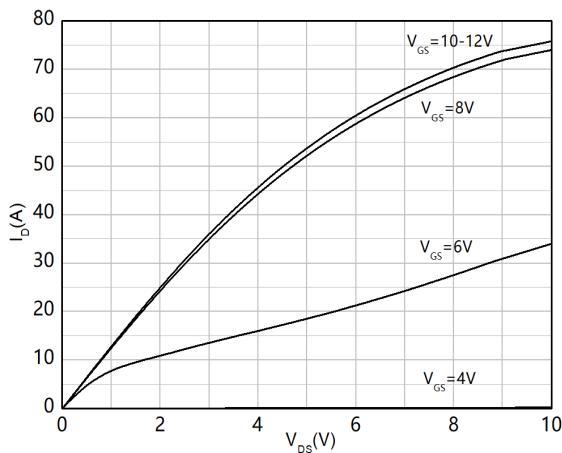


Figure 1. Typical Output Characteristics $T_j=25^\circ\text{C}$

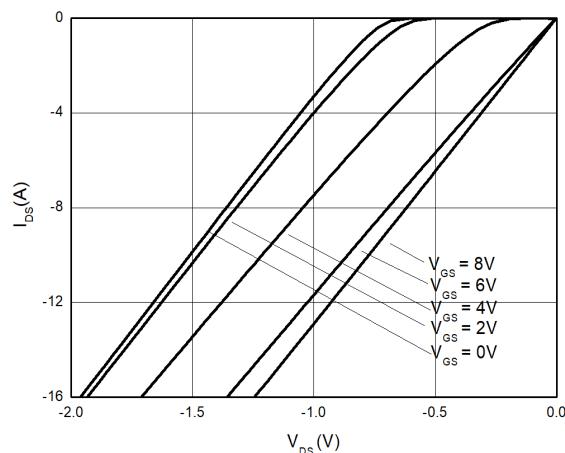


Figure 2. Channel Reverse Characteristics $T_j=25^\circ\text{C}$

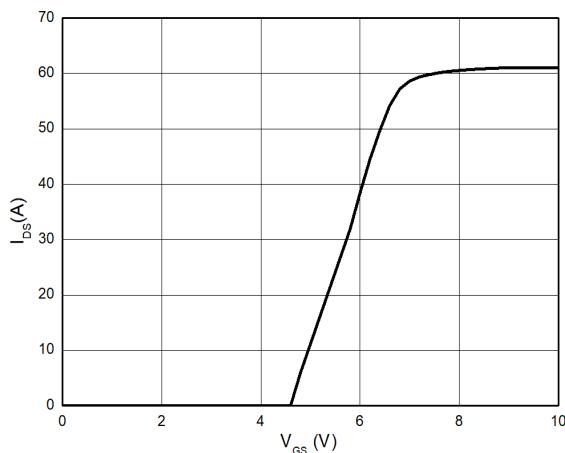


Figure 3. Typical Transfer Characteristics ($V_{DS}=10\text{V}$)

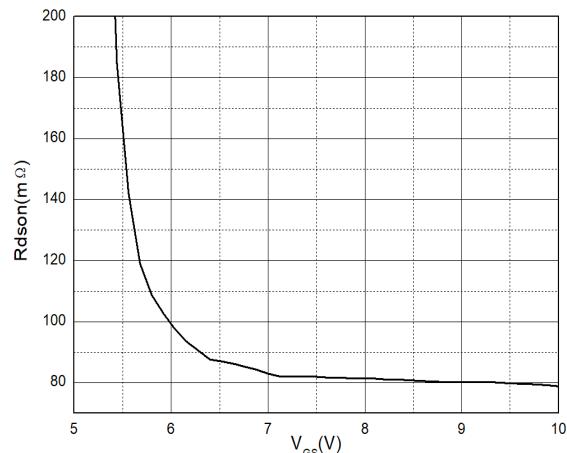


Figure 4. Typical On-state Resistance $T_j=25^\circ\text{C}$ ($I_D=1\text{A}$)

Typical Characteristics

$T_j=25^\circ\text{C}$ unless otherwise stated

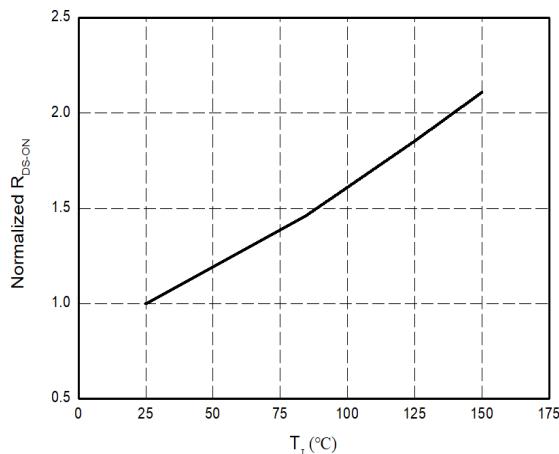


Figure 5. Normalized On-resistance

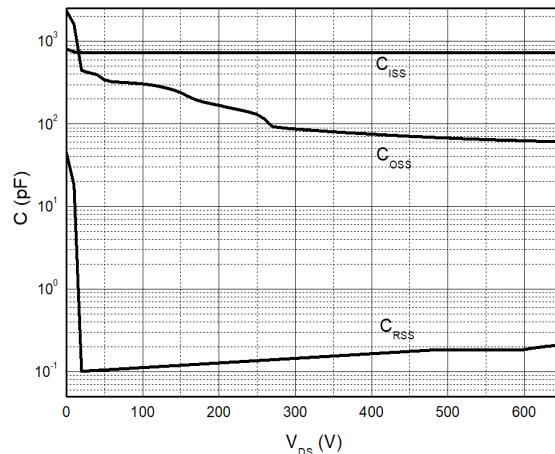


Figure 6. Typical Capacitance ($f=1\text{MHz}$)

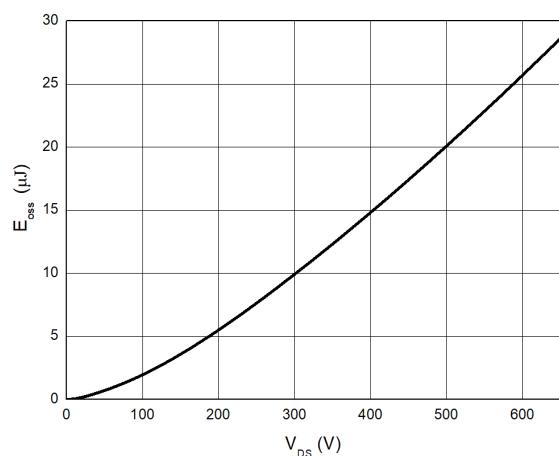


Figure 7. Typical C_{oss} Stored Energy

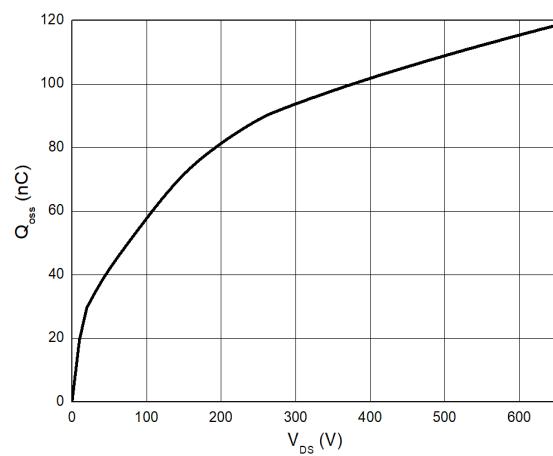


Figure 8. Typical Q_{oss}

Typical Characteristics

$T_j=25^\circ\text{C}$ unless otherwise stated

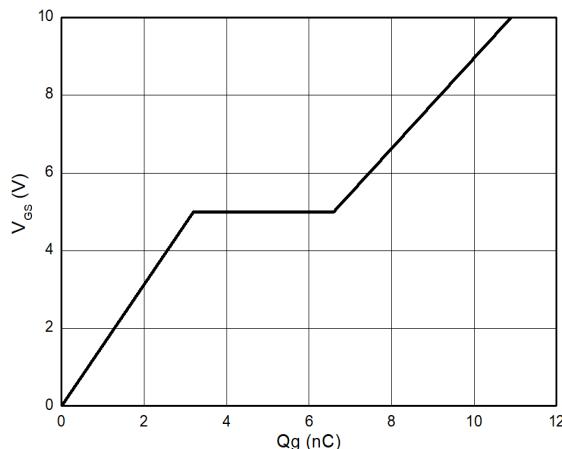


Figure 9. Typical Gate Charge ($V_{DS}=400\text{V}$, $I_D=1\text{A}$)

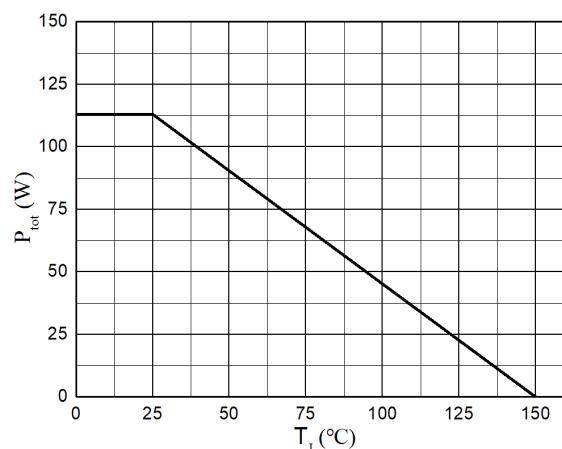


Figure 10. Power Dissipation

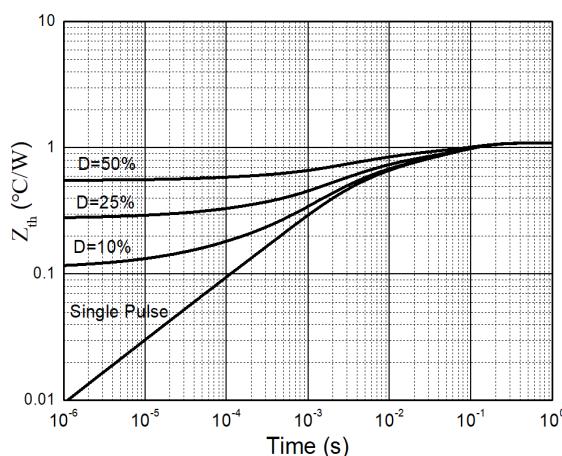


Figure 11. Transient Thermal Resistance

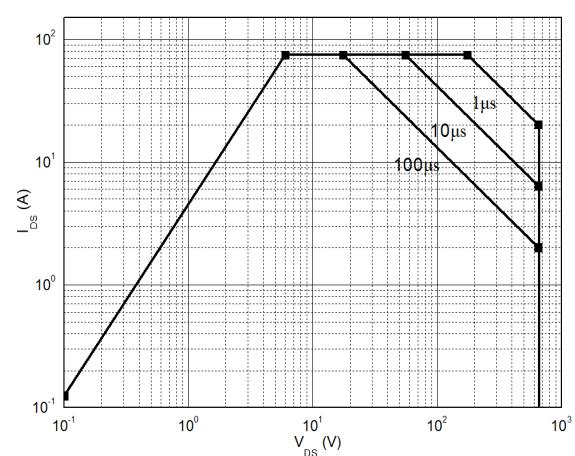


Figure 12. Safe Operating Area $T_j=25^\circ\text{C}$

Typical Characteristics

$T_j=25^\circ\text{C}$ unless otherwise stated

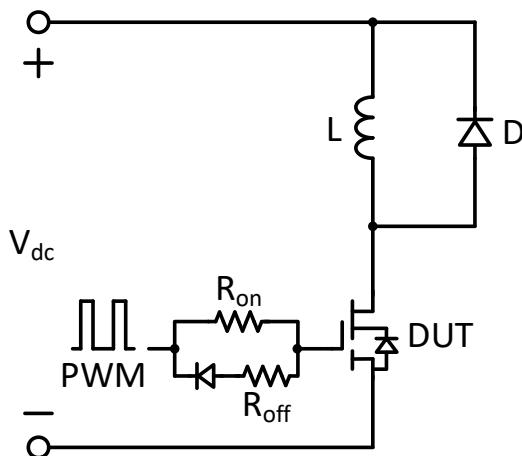


Figure 13. Switching times with inductive load

$V_{DS}=400\text{V}$, $V_{GS}=0\text{V}$ to 10V , $I_D=2.1\text{A}$,
 $R_{G-on(ext)}=6.8\Omega$, $R_{G-off(ext)}=2.2\Omega$, $L=250\mu\text{H}$

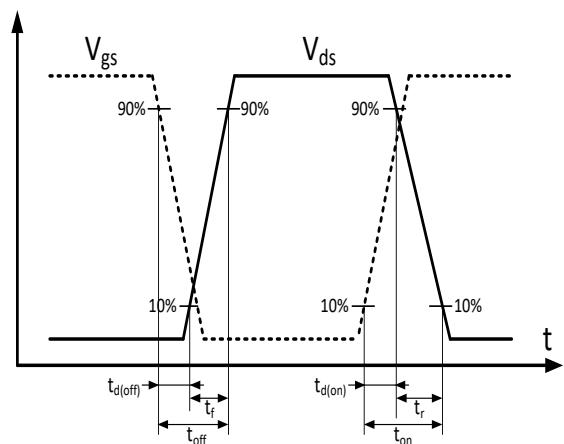
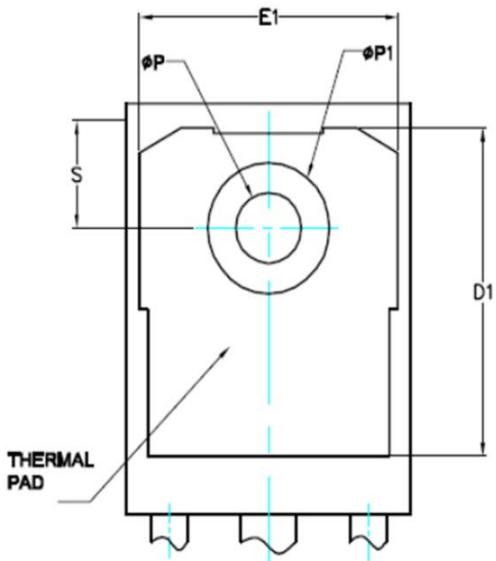
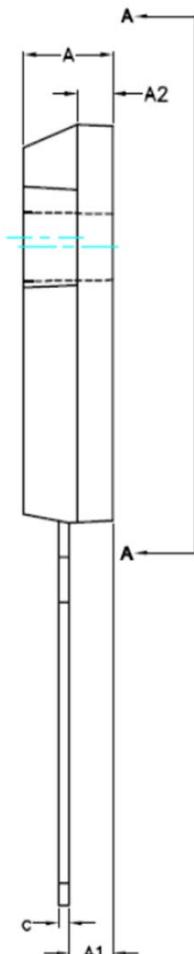
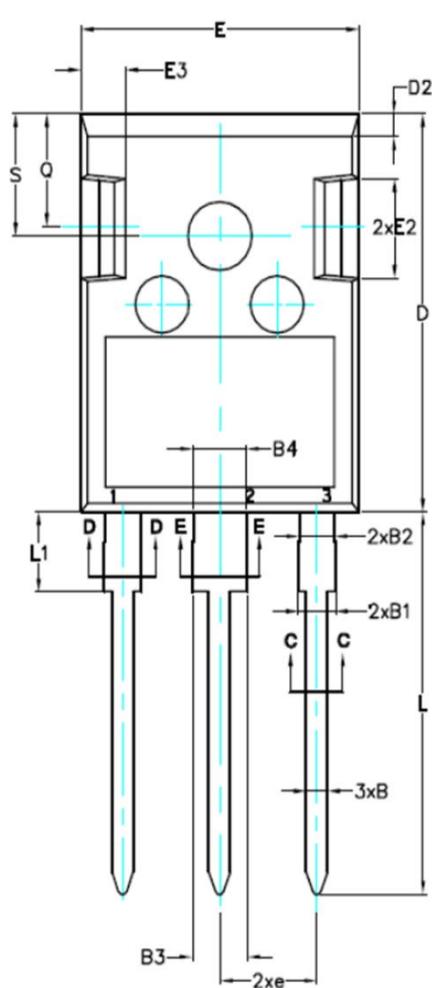


Figure 14. Switching times with waveform



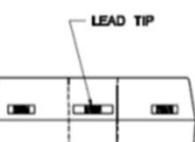
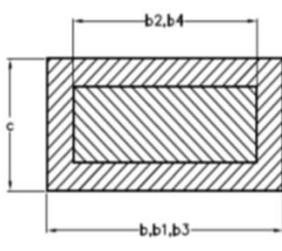
CE65H080TOCI

TO247-3L



VIEW A-A

SYMBOLS	DIMENSIONS			
	mm	inch	mm	inch
A	MIN. 4.85	MAX. 5.15	MIN. 0.191	MAX. 0.203
A1	2.25	2.55	0.088	0.100
A2	1.85	2.15	0.073	0.085
B	1.04	1.33	0.041	0.052
B1	1.90	2.35	0.075	0.093
B2	1.90	2.15	0.075	0.085
B3	2.90	3.35	0.114	0.132
B4	2.90	3.15	0.114	0.124
c	0.55	0.68	0.022	0.027
D	20.8	21.10	0.819	0.831
D1	16.25	17.65	0.640	0.695
D2	0.95	1.35	0.037	0.053
E	15.70	16.10	0.618	0.634
E1	13.50	14.20	0.531	0.559
E2	3.80	5.00	0.150	0.197
E3	1.00	2.6	0.039	0.102
e	5.46BSC		0.215BSC	
L	19.80	20.3	0.779	0.799
L1	4.00	4.50	0.157	0.177
φP	3.50	3.70	0.138	0.145
φP1	—	7.19	—	0.291
Q	5.40	6.00	0.212	0.236
S	6.2BSC		0.244BSC	





CE65H080TOCI

Revision history

Major changes since the last revision

Revision	Date	Description of changes
1.0	2024-07-20	Initial release